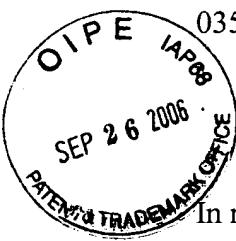


IFW

03500.018212.

PATENT APPLICATION



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:

TOSHIHIKO OUCHI

Application No.: 10/541,240

Int'l App No.: PCT/JP04/04348

Int'l Filing Date: March 26, 2004

For: HIGH FREQUENCY
ELECTRICAL SIGNAL
CONTROL DEVICE AND
SENSING SYSTEM

Examiner: Not Yet Assigned

Group Art Unit: 2626

September 25, 2006

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed below and on the enclosed Form PTO-1449. Copies of documents (3) to (6) are enclosed.

- (1) U.S. Patent Application Publication No. 2001/0049266
- (2) U.S. Patent No. 6,388,799
- (3) EP 0828143
- (4) EP 0852409
- (5) GB 2371618

(6) Nuss M C: "Chemistry Is Right for T-ray Imaging Laser, Microwave, and Signal Processing Technologies a Perfect Blend for Applications in Packaging, Security, and Quality Control" IEEE Circuits and Devices Magazine, IEEE Inc. New York, US, vol. 12, no. 2, 1 March 1996 (1996-03-01), pages 25-30, XP000589127 ISSN: 8755-3996.

Documents (1) to (6) were cited in a PCT International Search Report and/or a Written Opinion issued in the PCT application corresponding to the subject application. Copies of the PCT International Search Report and Written Opinion are enclosed.

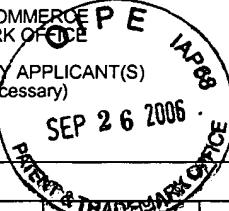
Inasmuch as this application has not yet received a first Office Action on the merits, it is believed that this Information Disclosure Statement is timely. See 37 C.F.R. § 1.97(b)(3). Accordingly, the Examiner is urged to study this information in its entirety and to form an independent determination of the materiality of the information to the claimed invention. Additionally, the Examiner is requested to indicate that this information has been considered by initialing the appropriate portion of the enclosed Form PTO-1449 and returning the initialed form to Applicant with the next communication.

Applicant's undersigned attorney may be reached in our Costa Mesa, California office by telephone at (714) 540-8700. All correspondence should continue to be directed to our address given below.

Respectfully submitted,


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ATTY DOCKET NO.
03500.018212.APPLICATION NO.
10/541,240APPLICANT
TOSHIHIKO OUCHIFILING DATE
July 1, 2005GROUP
2626

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	2001/0049266	12/2001	Hayata, et al.	455	81	
	6,388,799	05/2002	Arnone, et al.	359	326	

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
	0828143	03/1998	Europe			
	0852409	07/1998	Europe			
	2371618	07/2002	United Kingdom			

OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

Nuss M C: "Chemistry Is Right for T-ray Imaging Laser, Microwave, and Signal Processing Technologies a Perfect Blend for Applications in Packaging, Security, and Quality Control" IEEE Circuits and Devices Magazine, IEEE Inc. New York, US, vol. 12, no. 2, 1 March 1996 (1996-03-01), pages 25-30, XP000589127 ISSN: 8755-3996.

EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1